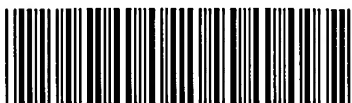


Search Notes

Application/Control No.

10/623,569

Examiner

Anish Desai

Applicant(s)/Patent under
Reexamination

MIYANO ET AL.

Art Unit

1771

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search using PALM	9/19/2005	APD
Inventor search using EAST	9/19/2005	APD
428/1.1,343,354 and 349/all subclasses (Text search only-see East search history printout)	9/19/2005	APD
Text search using EAST	9/19/2005	APD